

Proceeding Paper

Optimizing Germanium-Selective Functionalization on Patterned SiGe Substrates with Thiol-Based Molecules: The Critical Role of Oxygen-Free Conditions [†]

Alessi Arrigoni ^{1,*}, Federico Turco ¹, Benedetta Maria Squeo ¹, Sonia Freddi ², Monica Bollani ², Tersilla Virgili ³, Andrea Chiappini ⁴, Laura Pasquardini ⁵ and Mariacecilia Pasini ^{1,*}

¹ Institute of Chemical Sciences and Technologies (SCITEC)—CNR, 20133 Milano, Italy; federico.turco@scitec.cnr.it (F.T.); benedetta.squeo@scitec.cnr.it (B.M.S.)

² Institute of Photonic and Nanotechnology (IFN)—CNR, LNESS laboratory, 22100 Como, Italy; sonia.freddi@ifn.cnr.it (S.F.); monica.bollani@ifn.cnr.it (M.B.)

³ Institute of Photonic and Nanotechnology (IFN)—CNR, Piazza Leonardo da Vinci 32, 20133 Milano, Italy; tersilla.virgili@polimi.it

⁴ Institute of Photonic and Nanotechnology (IFN)—CNR and FBK Photonics Unit, Via alla Cascata 56/c, 38123 Trento, Italy; andrea.chiappini@unitn.it

⁵ Indivenire Srl, Via alla Cascata 56/C, 38123 Trento, Italy; l.pasquardini@indivenire.it

* Correspondence: alessia.arrigoni@scitec.cnr.it (A.A.); mariacecilia.pasini@scitec.cnr.it (M.P.)

[†] Presented at The 28th International Electronic Conference on Synthetic Organic Chemistry (ECSOC 2024), 15–30 November 2024; Available online: <https://sciforum.net/event/ecsoc-28>.

Abstract: Germanium offers attractive optical properties despite being an indirect bandgap semiconductor, and new Ge-based devices are being optimized for sensing and photonics applications. In particular, considering the use of Ge as a sensor, improving its selectivity via organic grafting offers new alternatives that are still under investigation. In this work we focus on selective functionalization of germanium in SiGe patterned alloys using a custom thiol-based luminescent molecule namely 6-[2,7-bis[5-(5-hexyl-2-thienyl)-2-thienyl]-9-(6-sulfanylhexyl)fluoren-9-yl]hexane-1-thiol. The process selectively targets regions with Ge, while leaving Si-rich areas uncovered. Moreover, the study emphasizes the importance of an oxygen-free environment, as performing the functionalization in an inert atmosphere significantly improves surface coverage.

Keywords: germanium; silicon; SiGe; functionalization; grafting; semiconductor

Citation: Arrigoni, A.; Turco, F.; Squeo, B.M.; Freddi, S.; Bollani, M.; Virgili, T.; Chiappini, A.; Pasquardini, L.; Pasini, M. Optimizing Germanium-Selective Functionalization on Patterned SiGe Substrates with Thiol-Based Molecules: The Critical Role of Oxygen-Free Conditions. *Chem. Proc.* **2024**, *6*, x. <https://doi.org/10.3390/xxxxx>

Academic Editor(s): Name

Published: date



Copyright: © 2024 by the authors. Submitted for possible open access publication under the terms and conditions of the Creative Commons Attribution (CC BY) license (<https://creativecommons.org/licenses/by/4.0/>).

1. Introduction

Silicon (Si) has been the preferred semiconductor for a wide range of electronic and microelectronic applications for over 40 years, largely due to its stable oxide (SiO₂). However, as modern microelectronics rapidly advance, there is increasing interest in germanium as a potential replacement for silicon in future-generation of optoelectronic devices [1–3]. This is because germanium exhibits higher carrier mobility and a narrower band gap. Nonetheless, the limited use of germanium platform as sensor is attributed to its unstable surface, including poor passivation, thermal instability, and water-soluble oxide [4,5]. Within this framework, achieving stable and high-coverage surface functionalization is essential for tuning and enhancing the material properties needed for these advanced technologies.

The functionalization of silicon surfaces involves well established protocols [6–10] and several molecules are reported to form stable monolayers on Si, meanwhile the current literature on germanium surface functionalization is quite limited. Additionally, literature on SiGe functionalization is even more restricted, with only few available examples [11–13].

The thiol group generally proposed as the best grafting system for Ge substrates is also the most promising candidate for the selective functionalization of SiGe surfaces. To study functionalization, we synthesized a luminescent model molecule with terminal thiol groups, which is easily detectable with confocal microscopy. The SiGe substrates are pre-treated with halide passivation (performed using HCl), leaving a Cl-terminated Ge. The substrates are then functionalized with the thiol-based 6-[2,7-bis[5-(5-hexyl-2-thienyl)-2-thienyl]-9-(6-sulfanylhexyl)fluoren-9-yl]hexane-1-thiol molecule.

In our work, we show that this process selectively functionalizes the SiGe pattern, where Ge is present while leaving almost uncovered the SiO₂ area, confirming the selective properties of the organic grafting. Here, we optimized conditions for effective SiGe grafting, highlighting the crucial role of oxygen. The study shows that performing the functionalization procedure in an oxygen-free atmosphere significantly enhances the extent of coverage on the substrate, highlighting the importance of an inert environment in achieving optimal functionalization results. For selectively functionalize germanium fractions on substrates made of SiGe patterns on a SiO₂ background, we have chosen to follow, as a reference, a protocol similar to the one used for the functionalization of germanium. In the literature, three main methods of functionalizing germanium are present: (i) Grignard chemistry [14,15], (ii) alkanethiol passivation [16,17], and (iii) hydrogermilation [18]. Both the Grignard chemistry and hydrogermilation approach result in the formation of a Ge-C bond, but can results also in a Si-C bond formation, while the alkanethiol passivation results in the selective creation of Ge-S bonds [19–21].

An additional challenge that needs to be addressed concerns the characterization technique used to evaluate the quality of surface grafting. Contact angle measurements and techniques such as XPS may not be sufficiently sensitive to detect grafting, which, in the case of complete surface coverage in an SiGe 30% system, would involve only 30% of the available surface. One of the most sensitive techniques is luminescence; for this reason, we decided to develop a luminescent molecule that could provide an immediate assessment of grafting quality. Among the most widely used luminescent molecules, fluorene-based compounds play a crucial role due to their ease of functionalization and high photoluminescence efficiency [22–24].

We have synthesized a custom thiol-based fluorene derivative designed to specifically meet our requirements: (i) selectively functionalize germanium by forming a Ge-S bond, and (ii) being easily detectable by fluorescence microscopy due to its fluorescent properties. The molecule we designed is a thiophene-fluorene based molecule with thiol-terminal alkyl chain, namely 6-[2,7-bis[5-(5-hexyl-2-thienyl)-2-thienyl]-9-(6-sulfanylhexyl)fluoren-9-yl]hexane-1-thiol (Bis-TTF).

Using the fluorescent molecule, we successfully demonstrated the effectiveness of S-H group functionalization through confocal microscopy. Additionally, our experiments revealed that working in the absence of oxygen, under inert atmosphere (nitrogen) during all the functionalization steps, significantly improves the efficiency of the functionalization, most likely because oxygen compete with thiol functionalization in the reformation of the surface oxide layer.

2. Materials and Methods

2.1. Materials

Organic grafting has been optimized on an alloy of Si_{1-x}Ge_x, with a Ge content (x) of about 30%. 26 nm of this SiGe alloy has been deposited in a molecular beam epitaxy reactor (MBE) on 14 nm thick monocrystalline silicon on insulator (on 25 nm thick buried oxide, BOX) previously diced in 2 cm × 2 cm samples [25]. To improve the selectivity of the organic grafting to the germanium element, all samples are pre-patterned to obtain germanium zones versus areas covered by thermal oxide or pure silicon. The SiGe or pure Ge area are patterned by optical lithography and transferred to the SiO₂ films by dry etching (CF₄ plasma) [26]. Specifically, the adhesion promoter Ti prime is spin-coated at 3000

rpm for 5 s, then the positive resist AZ 5214E is spin-coated in two different steps at 750 rpm for 5 s and at 4000 rpm for 40 s. By reactive ion etching (RIE), roughly 30 nm of SiGe or pure Ge are etched.

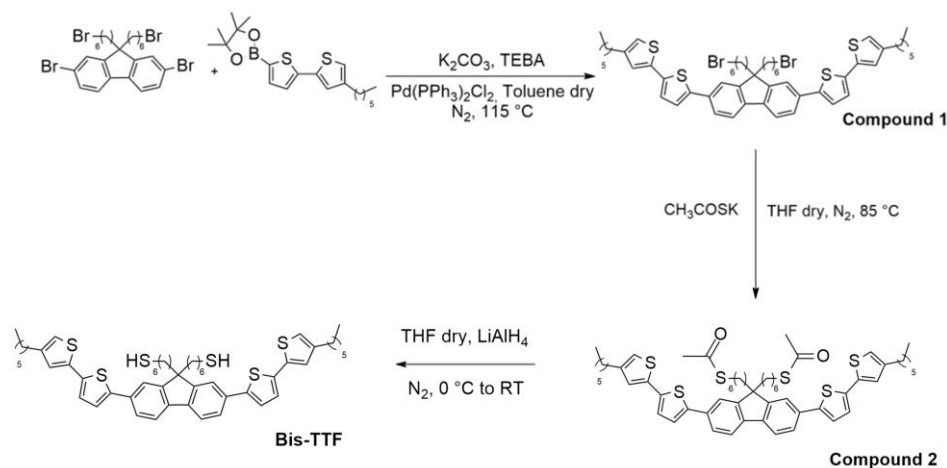
2.2. General Information for Synthesis

All reagents were purchased from commercial source and used without further purification. All solvents have been distilled prior to use. All reaction were carried out in inert atmosphere. The ^1H NMR spectra were recorded with a Bruker ARX 400 MHz spectrometer (Bruker, Karlsruhe, Germany).

Synthesis of compound 1. 260 mg (0.4 mmol) of Fluorene and 300 mg (0.8 mmol) of thiophene, 8.5 mg (3%) of $\text{Pd}(\text{PPh}_3)_2\text{Cl}_2$ catalyst and TEBA are placed in a Schlenk tube to undergo some Nitrogen-vacuum cycles. Then 6 ml of fresh distilled Toluene and 3 ml of a degassed 2M K_2CO_3 aqueous solution are added under Nitrogen. The reaction is heated at 115 °C in an oil bath overnight. The reaction mixture is diluted with EtOAc and washed 3 times with distilled water, then the organic phase is anhydrificated with sodium sulfate, filtered, and dried at rotary evaporator. The clean product ($M_w = 989.14$ g/mol) is obtained after a purification through a silica gel column, using as eluent an 8:2 mixture of Hexane and Dichloromethane with a final yield of 39% (154 mg).

Synthesis of compound 2. 154 mg (0.156 mmol) of compound 1, and 10 eq. (166 mg) of Potassium Thio-Acetate are placed in a Schlenk tube to undergo some Nitrogen-vacuum cycles. Then 3.5 mL of fresh distilled THF are added and the reaction is kept at 85 °C in an oil bath overnight. The reaction mixture is diluted with EtOAc and washed 3 times with distilled water and Brine. The organic phase is dehydrated with sodium sulfate, filtered and dried with rotary evaporator. The product is obtained after a chromatographic column with silica gel using a 6:4 to a 1:1 Hexane: Dichloromethane eluent mixture, yielding 98 mg (0.1 mmol; 64%) of clean product.

Synthesis of Bis-TTF molecule. The molecule is obtained through the reduction of thio-acetate moiety in thiol group. Compound 2.98 mg, is placed in a Schlenk tube to undergo Vacuum-Nitrogen cycles, then fresh distilled THF, 4ml, is added. A 1 M solution/dispersion of LiAlH_4 is prepared under nitrogen in another Schlenk tube in fresh distilled THF:15 mg of reductant (4 eq.), that underwent Nitrogen-vacuum cycles, in 0.4 ml of THF. The Schlenk tube is placed in an ice-bath and the 0,4 ml of the reductant solution is added; the reaction is kept at room temperature for half an hour and then 1 ml of AcOEt is added to avoid S-S dimer formation for another 30 min. The rection mixture is then diluted with EtOAc and washed with distilled water, the organic phase is anhydrificated with sodium sulfate, filtered and dried with rotary evaporator. The reaction is quantitative, leading to obtain 87 mg of the final product.



Scheme 1. Reaction scheme for the synthesis of Bis-TTF.

2.3. Substrates Functionalization Procedure

The SiGe substrates were cleaned using the following procedure: 10 min in acetone, 10 minutes in isopropanol, and then drying under a nitrogen flux. After cleaning, etching was performed by immersing the substrates in a 10% HCl solution for 10 min. The substrates were then rapidly immersed in deionized water and then in isopropanol. Next, the samples were immediately transferred into a solution of 2.25 mM of Bis-TTF molecule in a 6:4 mixture of ethyl acetate and THF at 50 °C for 24 h. Afterwards, the substrates were rinsed with fresh ethyl acetate and THF to remove any possible physisorbed molecule residue from the SiGe surface. Finally, the samples were blow-dried under nitrogen before characterization.

2.4. Characterization

Microscopy fluorescence images were collected with a Nikon Eclipse TE2000-U inverted confocal microscope by exciting with a 100 W Hg lamp with a 450–490 nm band-pass excitation filter.

3. Results

The passivation of germanium using alkanethiol involves a two-step process. First, the native oxide is removed, and then the passivation step is carried out. The native oxide can be eliminated by using halide acids (HX, where X = F, Cl, or Br) [27–30]. In this case, we used HCl, which results in a Cl-terminated surface. This surface is reactive towards thiols and oxides at a slower rate than an H-terminated Ge surface, allowing the material to be manipulated for a sufficient time in the laboratory [30].

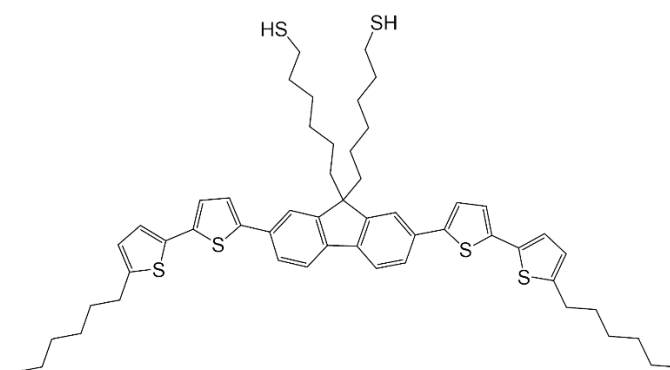


Figure 1. Chemical structure of the grafted molecule.

Bis-TTF (Figure 1) has been designed to attach to Ge using its thiol moieties. Its presence can be easily monitored using a fluorescence optical microscope because of its good fluorescence typical of fluorene-thiophene based molecules. We decided to attach a bithiophene to the fluorene instead of a single thiophene to shift the emission to a region that can be easily excited by the lamps of the confocal microscope [31]. This is important because we want to selectively functionalize only the regions of our samples where Ge is present (specifically the SiGe pattern). Therefore, if the attachment is effective and selective, we expect to detect a luminescent pattern where the molecule is attached by shining UV light on the sample. Fluorescence microscopy images in Figure 2a,b highlight the preferential selective functionalization in atmospheric condition (moisture and oxygen) mostly occurring in correspondence of the SiGe pattern. It is indeed possible to follow the pattern of an H letter in panels (a) and (b).

To increase the coverage of functionalization on the germanium, we attempted to minimize the presence of oxygen during the procedure by operating with distilled solvents and under nitrogen atmosphere. As mentioned earlier, when exposed to oxygen,

silicon and germanium create an oxide layer when exposed to air. It is indeed possible that the formation of germanium oxide could compete with the grafting of thiol molecules, thereby limiting their bonding to the surface.

Working in a nitrogen atmosphere results in increased functionalization of the germanium portion, as shown in Figure 2, panels (c) and (d). It is possible to follow the pattern of an R and A letters in panels (c) and (d) respectively.

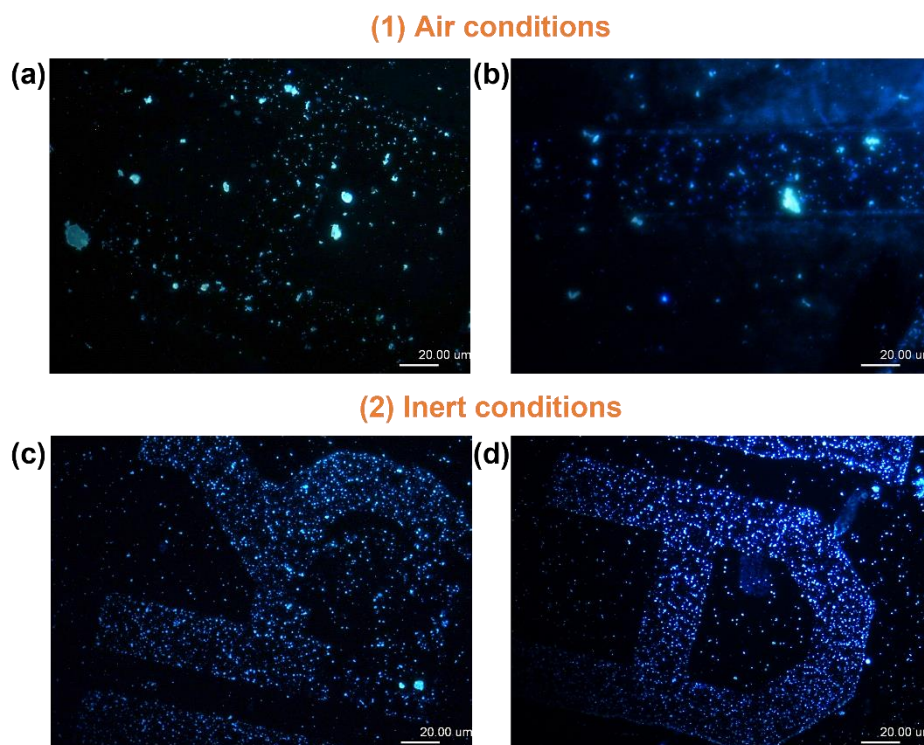


Figure 2. Fluorescence microscopy images of SiGe samples functionalized in (1) air and (2) under inert conditions. Samples are irradiated by UV light.

4. Conclusions

Our experiments demonstrate the successful selective functionalization of Ge in pre-patterned SiGe films. These findings highlight the effectiveness of confocal microscopy in detecting grafting, made possible through the use of appropriate fluorescent molecules. Furthermore, we observed that, unlike pure Ge surfaces, the elimination of oxygen plays a crucial role in SiGe systems. Specifically, we underscore the detrimental impact of oxygen during the process, as its presence results in reduced substrate functionalization. This may be attributed to the greater susceptibility of Ge to oxidation when present in alloys like SiGe 30%. To mitigate this effect, we have shown that performing the process in a nitrogen atmosphere leads to optimal results. Additional analyses, such as XPS and TOF-SIMS, will be conducted to confirm the presence of Ge-S bonds.

Author Contributions: Conceptualization, M.P., B.M.S. and M.B.; methodology, B.M.S., M.P., A.A. and S.F.; validation, B.M.S., M.P., A.A. and S.F.; investigation, A.A., S.F. and F.T.; resources, M.P. and M.B.; writing—original draft preparation, A.A.; writing—review and editing, B.M.S., M.P., M.B., T.V., A.C. and L.P.; funding acquisition, M.P. and M.B. All authors have read and agreed to the published version of the manuscript.

Funding: This research was funded by the project CNR “EPOCALE” (2022–2024), European Commission (grant n° 828890) and by PRIN2022 PNRR “ACONITE” (Finanziato dall’Unione europea—Next Generation EU, grant n° P2022HRTYH).

Institutional Review Board Statement:

Informed Consent Statement:**Data Availability Statement:****Conflicts of Interest:** The authors declare no conflicts of interest.**References**

1. Giliberti, V.; Sakat, E.; Bollani, M.; Altoe, M.V.; Melli, M.; Weber-Bargioni, A.; Baldassarre, L.; Celebrano, M.; Frigerio, J.; Isella, G.; et al. Functionalization of Scanning Probe Tips with Epitaxial Semiconductor Layers. *Small Methods* **2017**, *1*, 1600033. <https://doi.org/10.1002/smt.201600033>.
2. Lodari, M.; Biagioni, P.; Ortolani, M.; Baldassarre, L.; Isella, G.; Bollani, M. Plasmon-Enhanced Ge-Based Metal-Semiconductor-Metal Photodetector at near-IR Wavelengths. *Opt. Express* **2019**, *27*, 20516–20524. <https://doi.org/10.1364/OE.27.020516>.
3. Bouabdellaoui, M.; Bollani, M.; Salvalaglio, M.; Assaf, E.; Favre, L.; Abel, M.; Ronda, A.; Gourhant, O.; Deprat, F.; Duluard, C.; et al. Engineering Epitaxy and Condensation: Fabrication of Ge Nanolayers, Mechanism and Applications. *Appl. Surf. Sci.* **2023**, *630*, 157226. <https://doi.org/10.1016/j.apsusc.2023.157226>.
4. Cai, Q.; Xu, B.; Ye, L.; Di, Z.; Huang, S.; Du, X.; Zhang, J.; Jin, Q.; Zhao, J. 1-Dodecanethiol Based Highly Stable Self-Assembled Monolayers for Germanium Passivation. *Appl. Surf. Sci.* **2015**, *353*, 890–901. <https://doi.org/10.1016/j.apsusc.2015.06.174>.
5. Loscutoff, P.W.; Bent, S.F. Reactivity of the Germanium Surface: Chemical Passivation and Functionalization. *Annu. Rev. Phys. Chem.* **2006**, *57*, 467–495. <https://doi.org/10.1146/annurev.physchem.56.092503.141307>.
6. Ciampi, S.; Harper, J.B.; Gooding, J.J. Wet Chemical Routes to the Assembly of Organic Monolayers on Silicon Surfaces via the Formation of Si–C Bonds: Surface Preparation, Passivation and Functionalization. *Chem. Soc. Rev.* **2010**, *39*, 2158–2183. <https://doi.org/10.1039/B923890P>.
7. Onclin, S.; Ravoo, B.J.; Reinhoudt, D.N.; Ravoo, B.J.; Reinhoudt, D.N.; Onclin, S. Engineering Silicon Oxide Surfaces Using Self-Assembled Monolayers. *Angew. Chem. Int. Ed.* **2005**, *44*, 6282–6304. <https://doi.org/10.1002/anie.200500633>.
8. Chehimi, M.M. Aryl Diazonium Salts: New Coupling Agents in Polymer and Surface Science. In *Aryl Diazonium Salts: New Coupling Agents in Polymer and Surface Science*; John Wiley & Sons: Hoboken, NJ, USA, 2012. <https://doi.org/10.1002/9783527650446>.
9. Girard, A.; Geneste, F.; Coulon, N.; Cardinaud, C.; Mohammed-Brahim, T. SiGe Derivatization by Spontaneous Reduction of Aryl Diazonium Salts. *Appl. Surf. Sci.* **2013**, *282*, 146–155. <https://doi.org/10.1016/j.apsusc.2013.05.091>.
10. Bollani, M.; Piagge, R.; Charai, A.; Narducci, D. Experimental Evidence and Computational Analysis of the Electronic Density Modulation Induced by Gaseous Molecules at Si(001) Surfaces upon Self-Assembling Organic Monolayer. *Appl. Surf. Sci.* **2001**, *175–176*, 379–385. [https://doi.org/10.1016/S0169-4332\(01\)00129-5](https://doi.org/10.1016/S0169-4332(01)00129-5).
11. Kaufman-Osborn, T.; Chagarov, E.A.; Park, S.W.; Sahu, B.; Siddiqui, S.; Kummel, A.C. Atomic Imaging and Modeling of Passivation, Functionalization, and Atomic Layer Deposition Nucleation of the SiGe(001) Surface via H₂O₂(g) and Trimethylaluminum Dosing. *Surf. Sci.* **2014**, *630*, 273–279. <https://doi.org/10.1016/j.susc.2014.08.027>.
12. Lenci, S.; Caponigri, I.; Lande, C.; Nannini, A.; Pennelli, G.; Pieri, F.; Severi, S.; Tedeschi, L. Selective Organic Functionalization of Polycrystalline Silicon-Germanium for BioMEMS Applications. *Procedia Chem.* **2009**, *1*, 252–255. <https://doi.org/10.1016/j.proche.2009.07.063>.
13. Girard, A.; Geneste, F.; Coulon, N.; Cardinaud, C.; Mohammed-Brahim, T. SiGe Derivatization by Spontaneous Reduction of Aryl Diazonium Salts. *Appl. Surf. Sci.* **2013**, *282*, 146–155. <https://doi.org/10.1016/j.apsusc.2013.05.091>.
14. Yuan, S.; Wang, S.; Xu, Z.; Amick, J.A.; Cullen, G.W.; Gerlich, D. The Stabilization of Germanium Surfaces by Ethylation: I. Chemical Treatment. *J. Electrochem. Soc.* **1962**, *109*, 124. <https://doi.org/10.1149/1.2425342>.
15. He, J.; Lu, Z.H.; Mitchell, S.A.; Wayner, D.D.M. Self-Assembly of Alkyl Monolayers on Ge(111)1a. *J. Am. Chem. Soc.* **1998**, *120*, 2660–2661. <https://doi.org/10.1021/ja974119s>.
16. Ardalan, P.; Sun, Y.; Pianetta, P.; Musgrave, C.B.; Bent, S.F. Reaction Mechanism, Bonding, and Thermal Stability of 1-Alkanethiols Self-Assembled on Halogenated Ge Surfaces. *Langmuir* **2010**, *26*, 8419–8429. <https://doi.org/10.1021/la904864c>.
17. Kosuri, M.R.; Cone, R.; Li, Q.; Han, S.M.; Bunker, B.C.; Mayer, T.M. Adsorption Kinetics of 1-Alkanethiols on Hydrogenated Ge(111). *Langmuir* **2004**, *20*, 835–840. <https://doi.org/10.1021/la035521p>.
18. Choi, K.; Buriak, J.M. Hydrogermylation of Alkenes and Alkynes on Hydride-Terminated Ge(100) Surfaces. *Langmuir* **2000**, *16*, 7737–7741. <https://doi.org/10.1021/la000413d>.
19. Fabre, B. Functionalization of Oxide-Free Silicon Surfaces with Redox-Active Assemblies. *Chem. Rev.* **2016**, *116*, 4808–4849. <https://doi.org/10.1021/acs.chemrev.5b00595>.
20. Bashouti, M.Y.; Stelzner, T.; Christiansen, S.; Haick, H. Covalent Attachment of Alkyl Functionality to 50 Nm Silicon Nanowires through a Chlorination/Alkylation Process. *J. Phys. Chem. C* **2009**, *113*, 14823–14828. <https://doi.org/10.1021/jp905394w>.
21. Li, Y.; Calder, S.; Yaffe, O.; Cahen, D.; Haick, H.; Kronik, L.; Zuillhof, H. Hybrids of Organic Molecules and Flat, Oxide-Free Silicon: High-Density Monolayers, Electronic Properties, and Functionalization. *Langmuir* **2012**, *28*, 9920–9929. <https://doi.org/10.1021/la3010568>.
22. Lattante, S.; De Giorgi, M.L.; Pasini, M.; Anni, M. Low Threshold Amplified Spontaneous Emission Properties in Deep Blue of Poly[(9,9-Dioctylfluorene-2,7-Diyl)-Alt-p-Phenylene] Thin Films. *Opt. Mater.* **2017**, *72*, 765–768. <https://doi.org/10.1016/j.optmat.2017.07.025>.

23. Virgili, T.; Anni, M.; De Giorgi, M.L.; Varillas, R.B.; Squeo, B.M.; Pasini, M. Deep Blue Light Amplification from a Novel Triphenylamine Functionalized Fluorene Thin Film. *Molecules* **2019**, *25*, 79. <https://doi.org/10.3390/molecules25010079>.
24. Giovanella, U.; Betti, P.; Bolognesi, A.; Destri, S.; Melucci, M.; Pasini, M.; Porzio, W.; Botta, C. Core-Type Polyfluorene-Based Copolymers for Low-Cost Light-Emitting Technologies. *Org. Electron.* **2010**, *11*, 2012–2018. <https://doi.org/10.1016/j.orgel.2010.09.009>.
25. Granchi, N.; Fagiani, L.; Barri, C.; Fedorov, A.; Abbarchi, M.; Vincenti, M.A.; Intonti, F.; Bollani, M. Light Scattering Features Induced by Residual Layers in Dielectric Dewetted Nanoparticles. *Opt. Mater. Express* **2023**, *13*, 3394–3404. <https://doi.org/10.1364/OME.498142>.
26. Barri, C.; Mafakheri, E.; Fagiani, L.; Tavani, G.; Barzaghi, A.; Chrastina, D.; Fedorov, A.; Frigerio, J.; Lodari, M.; Scotognella, F.; et al. Engineering of the Spin on Dopant Process on Silicon on Insulator Substrate. *Nanotechnology* **2020**, *32*, 025303. <https://doi.org/10.1088/1361-6528/abbdda>.
27. Molina, A.; Shallenberger, J.R.; Mohny, S.E. Vapor Phase Passivation of (100) Germanium Surfaces with HBr. *J. Vac. Sci. Technol. A Vac. Surf. Film.* **2020**, *38*, 23208. <https://doi.org/10.1116/1.5141941>.
28. Park, K.; Lee, Y.; Lee, J.; Lim, S. Oxidation Mechanism of Hydrogen-Terminated Ge(1 0 0) Surface. *Appl. Surf. Sci.* **2008**, *254*, 4828–4832. <https://doi.org/10.1016/j.apsusc.2008.01.114>.
29. van Dorp, D.H.; Weinberger, D.; Van Wonterghem, S.; Arnauts, S.; Strubbe, K.; Holsteyns, F.; De Gendt, S. Nanoscale Etching: Dissolution of III-As and Ge in HCl/H₂O₂ Solutions. *ECS Trans.* **2015**, *69*, 235–242. <https://doi.org/10.1149/06908.0235ecst>.
30. Kim, J.; McVittie, J.; Saraswat, K.; Nishi, Y.; Liu, S.; Tan, S. Germanium Surface Cleaning with Hydrochloric Acid. *ECS Trans.* **2006**, *3*, 1191–1196. <https://doi.org/10.1149/1.2355913>.
31. Porzio, W.; Destri, S.; Pasini, M.; Giovanella, U.; Ragazzi, M.; Scavia, G.; Kotowski, D.; Zotti, G.; Vercelli, B. Synthesis and Characterisation of Fluorenone–Thiophene-Based Donor–Acceptor Oligomers: Role of Moiety Sequence upon Packing and Electronic Properties. *New J. Chem.* **2010**, *34*, 1961–1973. <https://doi.org/10.1039/C0NJ00045K>.

Disclaimer/Publisher's Note: The statements, opinions and data contained in all publications are solely those of the individual author(s) and contributor(s) and not of MDPI and/or the editor(s). MDPI and/or the editor(s) disclaim responsibility for any injury to people or property resulting from any ideas, methods, instructions or products referred to in the content.